

<b>Notice of References Cited</b>	Application/Control No. 10/630,390	Applicant(s)/Patent Under Reexamination CHUEY, MARK D.	
	Examiner Kiet Doan	Art Unit 2683	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,025,785 A	02-2000	Farris et al.	340/5.23
*	B	US-2002/0163440 A1	11-2002	Tsui, Philip Y.W.	340/825.69
*	C	US-2002/0075133 A1	06-2002	Flick, Kenneth E.	340/5.64
*	D	US-6,154,544 A	11-2000	Farris et al.	380/262
*	E	US-5,872,513 A	02-1999	Fitzgibbon et al.	340/5.28
*	F	US-5,949,349 A	09-1999	Farris et al.	340/5.26
*	G	US-6,956,460 B2	10-2005	Tsui, Philip Y.W.	340/5.26
*	H	US-6,690,796 B1	02-2004	Farris et al.	380/239
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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